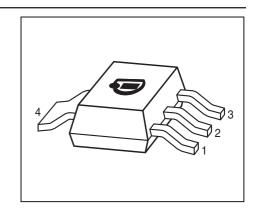


NPN Silicon Darlington Transistors

- High collector current
- Low collector-emitter saturation voltage
- Complementary types: BSP60 BSP62 (PNP)
- Pb-free (RoHS compliant) package
- Qualified according AEC Q101







Туре	Marking	Pin Configuration						Package
BSP50	BSP50	1=B	2=C	3=E	4=C	-	-	SOT223
BSP51	BSP51	1=B	2=C	3=E	4=C	-	-	SOT223
BSP52	BSP52	1=B	2=C	3=E	4=C	-	-	SOT223

Maximum Ratings

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V_{CEO}		V
BSP50		45	
BSP51		60	
BSP52		80	
Collector-base voltage	V _{CBO}		
BSP50		60	
BSP51		80	
BSP52		90	
Emitter-base voltage	V _{EBO}	5	
Collector current	I _C	1	Α
Peak collector current, $t_p \le 10 \text{ ms}$	I _{CM}	2	
Base current	I _B	100	mA
Total power dissipation-	P _{tot}	1.5	W
<i>T</i> _S ≤ 124 °C			
Junction temperature	$T_{\rm j}$	150	°C
Storage temperature	T _{stg}	-65 150	

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Thermal Resistance

Parameter	Symbol	Value	Unit
Junction - soldering point ¹⁾	R _{thJS}	≤ 17	K/W

Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

Parameter	Symbol	Values			Unit
		min.	typ.	max.	
DC Characteristics				•	•
Collector-emitter breakdown voltage	V _{(BR)CEO}				V
$I_{\rm C}$ = 10 mA, $I_{\rm B}$ = 0 , BSP50		45	-	-	
$I_{\rm C}$ = 10 mA, $I_{\rm B}$ = 0 , BSP51		60	-	-	
$I_{\rm C}$ = 10 mA, $I_{\rm B}$ = 0 , BSP52		80	-	-	
Collector-base breakdown voltage	V _{(BR)CBO}				
$I_{\rm C}$ = 100 μ A, $I_{\rm E}$ = 0 , BSP50		60	-	_	
$I_{\rm C}$ = 100 μ A, $I_{\rm E}$ = 0 , BSP51		80	-	_	
$I_{\rm C}$ = 100 μ A, $I_{\rm E}$ = 0 , BSP52		90	-	-	
Emitter-base breakdown voltage	V _{(BR)EBO}	5	-,	-	
$I_{\rm E}$ = 100 µA, $I_{\rm C}$ = 0					
Collector-emitter cutoff current	I _{CES}	-	-	10	μA
$V_{\text{CE}} = V_{\text{CE0max}}, V_{\text{BE}} = 0$					
Emitter-base cutoff current	I _{EBO}	-	-	10	μA
$V_{\rm EB} = 4 \text{ V}, I_{\rm C} = 0$					
DC current gain ²⁾	h _{FE}				-
$I_{\rm C}$ = 150 mA, $V_{\rm CE}$ = 10 V		1000	-	-	
$I_{\rm C}$ = 500 mA, $V_{\rm CE}$ = 10 V		2000	-	-	
Collector-emitter saturation voltage ²⁾	V _{CEsat}				V
$I_{\rm C}$ = 500 mA, $I_{\rm B}$ = 0.5 mA		-	-	1.3	
$I_{\rm C}$ = 1 A, $I_{\rm B}$ = 1 mA		-	-	1.8	
Base emitter saturation voltage ²⁾	V _{BEsat}				
$I_{\rm C}$ = 500 mA, $I_{\rm B}$ = 0.5 mA		-	-	1.9	
$I_{\rm C}$ = 1 mA, $I_{\rm B}$ = 1 A		-	_	2.2	

 $^{^{1}}$ For calculation of R_{thJA} please refer to Application Note AN077 (Thermal Resistance Calculation)

 $^{^{2}}$ Pulse test: t < 300µs; D < 2%

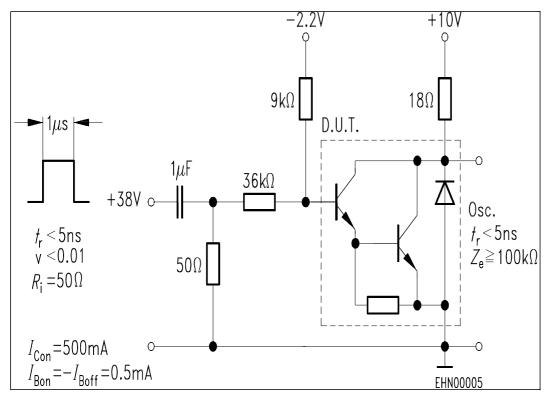


Electrical Characteristics at $T_A = 25$ °C, unless otherwise specified

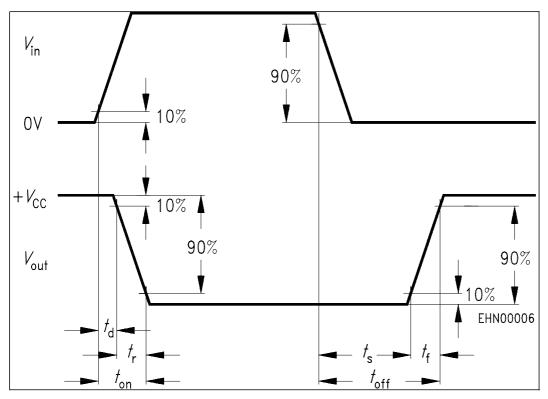
Parameter	Symbol	Values		Unit	
		min.	typ.	max.	
AC Characteristics	·	•	•	•	•
Transition frequency	f_{T}	-	200	-	MHz
$I_{\rm C}$ = 100 mA, $V_{\rm CE}$ = 5 V, f = 100 MHz					
Tum-on time	$t_{(on)}$	-	400	-	ns
$I_{\rm C}$ = 500 mA, $I_{\rm B1}$ = $I_{\rm B2}$ = 0.5 mA					
Tum-off time	$t_{({\sf off})}$	-	1500	-	
$I_{\rm C}$ = 500 mA, $I_{\rm B1}$ = $I_{\rm B2}$ = 0.5 mA					



Switching time test circuit



Switching time waveform

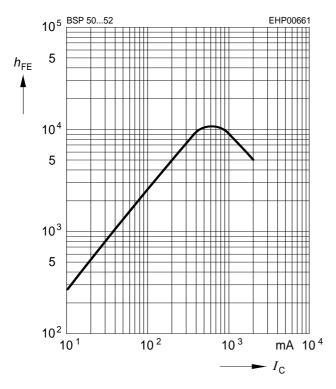


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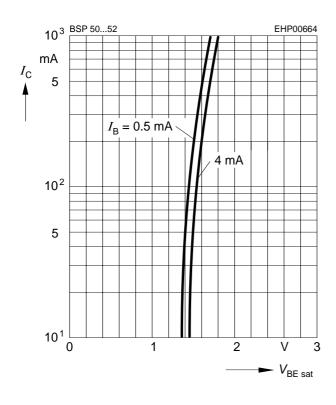
DC current gain $h_{FE} = f(I_C)$

$$V_{CE}$$
 = 10 V



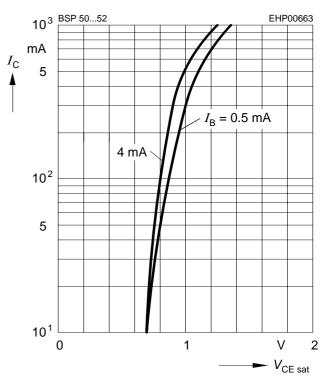
Base-emitter saturation voltage

$$I_{\rm C} = f(V_{\rm BEsat}), I_{\rm B} = {\rm Parameter}$$



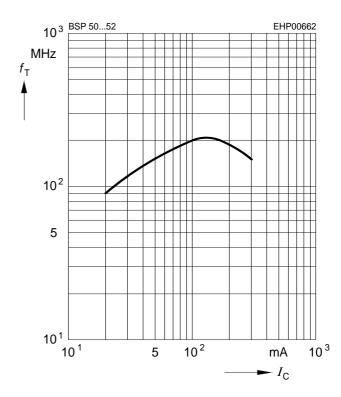
Collector-emitter saturation voltage

 $I_{C} = f(V_{CEsat}), I_{B} = Parameter$



Transition frequency $f_T = f(I_C)$

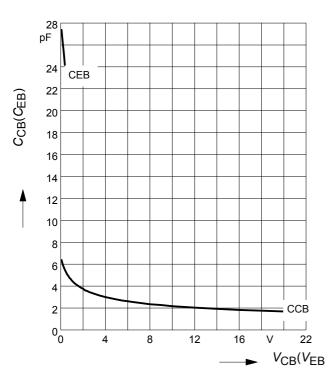
$$V_{CE} = 5 \text{ V}, f = 100 \text{ MHz}$$

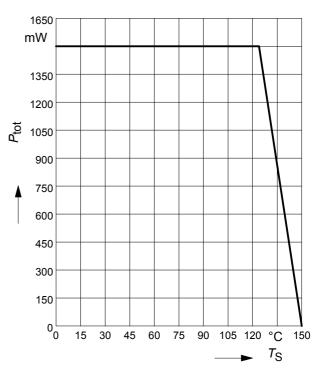




Collector-base capacitance $C_{\text{cb}} = f(V_{\text{CB}})$ Emitter-base capacitance $C_{\text{eb}} = f(V_{\text{EB}})$

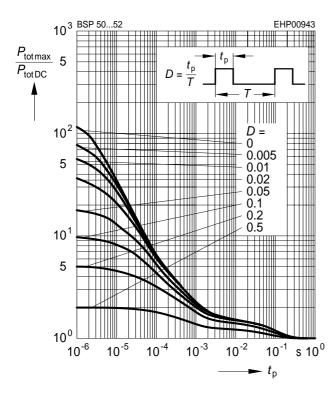
Total power dissipation $P_{tot} = f(T_S)$





Permissible Pulse Load

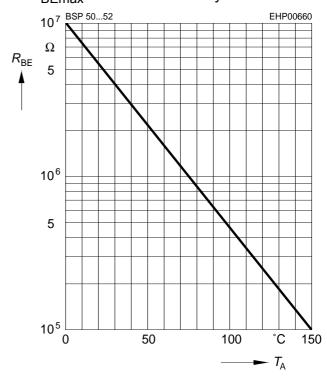
 $P_{\text{totmax}}/P_{\text{totDC}} = f(t_{\text{p}})$



External resistance $R_{BE} = f (T_A)^{**}$

$$V_{CB} = V_{CEmax}$$

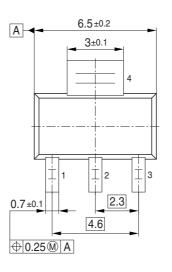
** R_{BEmax} for thermal stability

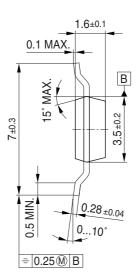




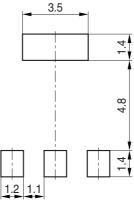
Package Outline



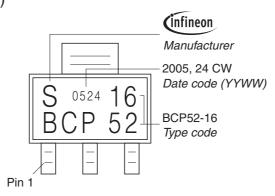




Foot Print

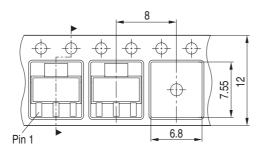


Marking Layout (Example)



Packing

Reel ø180 mm = 1.000 Pieces/Reel Reel ø330 mm = 4.000 Pieces/Reel







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